

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10816450	CHUN ET AL.
	Examiner	Art Unit
	BENJAMIN P GEIB	2181

SEARCHED

Class	Subclass	Date	Examiner
712	245	6/16/2010	BPG

SEARCH NOTES

Search Notes	Date	Examiner
Updated EAST search	6/16/2010	BPG
Updated NPL search (Google Scholar and IEEE Xplore)	6/16/2010	BPG
Inventor name search	6/16/2010	BPG

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
712	245	6/16/2010	BPG

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